


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/628,237	SHIZUKUISHI, MAKOTO	
	Examiner	Art Unit	
	Nhan T. Tran	2622	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST search (USPAT, PGPUB, JPO, EPO, DERWENT, IBM_TDB) text search - see search history printout	11/13/2006	NT
348/294-324 348/231.1-231.9 (text search - see search history printout)	11/16/2006	NT
text search class 257 - see search history printout	11/16/2006	NT
365/185.01-185.33 365/230.01-230.09 (text search - see search history printout)	11/22/2006	NT
Inventorship search - see search history printout	11/26/2003	NT